


<b>Search Notes</b>  	<b>Application/Control No.</b>  10587094	<b>Applicant(s)/Patent Under Reexamination</b>  LI ET AL.
	<b>Examiner</b>  PETER COUGHLAN	<b>Art Unit</b>  2129

SEARCHED			
Class	Subclass	Date	Examiner
706	@pd<20050811 with matrix and 12, 16, 45	12/4/2008	PDC
706	@pd<20050811 and 12	7/29/2009	PDC

SEARCH NOTES		
Search Notes	Date	Examiner
Inventors -- Eric Q. Li, Qian Diao	12/3/2008	PDC
East @ pd<20050811 and value, group, feature, training data, update, eliminated, computing, generating, kernel, buffer, memory, dot product, ranking, determine, image, reduction, elimination	12/3/2008	PDC
East @pd<20050811 and apparatus, svm-rfe	7/29/2009	PDC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--